SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUADRUPLE 1-OF-2 DATA SELECTORS/MULTIPLEXERS SDAS081C – APRIL 1982 – REVISED DECEMBER 1994

- Buffered Inputs and Outputs
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These data selectors/multiplexers contain inverters and drivers to supply full data selection to the four output gates. A separate strobe (\overline{G}) input is provided. A 4-bit word is selected from one of two sources and is routed to the four outputs. The 'ALS157A and SN74AS157 present true data. The 'ALS158 and SN74AS158 present inverted data to minimize propagation delay time.

The SN54ALS157A and SN54ALS158 are characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ALS157A, SN74ALS158, SN74AS157, and SN74AS158 are characterized for operation from 0° C to 70° C.

SN54ALS157A, SN54ALS158 J PACKAGE
SN74ALS157A, SN74ALS158,
SN74AS157, SN74AS158 D OR N PACKAGE
(TOP VIEW)

1Y 4 13 4B 2A 5 12 4Y 2B 6 11 3A 2Y 7 10 3B GND 8 9 3Y	1B 1Y 2A 2B 2Y	5 6 7	υ	13 12 11 10] 4Y] 3A] 3B
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SN54ALS157A, SN54ALS158 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

		F	UNCT	ON TABLE				
	INP	JTS		OUTPUT Y				
<u> </u>	-	DA	TA	ALS157A	′ALS158			
G	Ā/B	Α	В	SN74AS157	SN74AS158			
н	Х	Х	Х	L	Н			
L	L	L	Х	L	н			
L	L	н	Х	н	L			
L	Н	Х	L	L	н			
L	Н	Х	Н	н	L			

FUNCTION TABLE

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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logic symbols[†]



 \dagger These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.



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Pin numbers shown are for the D, J, and N packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC} Input voltage, V _I	
Operating free-air temperature range, T _A : SN54ALS157A, SN54ALS158	–55°C to 125°C
SN74ALS157A, SN74ALS158	
Storage temperature range	−65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

				-	SN74ALS157A SN74ALS158			
		MIN	NOM	MAX	MIN	NOM	MAX	
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			-0.4			-0.4	mA
IOL	Low-level output current			4			8	mA
Τ _Α	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST C	ONDITIONS		54ALS15 54ALS1		-	74ALS15 74ALS1		UNIT	
				MIN	TYP‡	MAX	MIN	TYP‡	MAX		
VIK		V _{CC} = 4.5 V,	lı = –18 mA			-1.2			-1.2	V	
VOH		V_{CC} = 4.5 V to 5.5 V,	I _{OH} = -0.4 mA	V _{CC} -2	2		V _{CC} -2	2		V	
Ve		V _{CC} = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4).4 V	
VOL		VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	v	
Ц		V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA	
Iн		V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μA	
۱ _{IL}		V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1			-0.1	mA	
IO§		V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
	′ALS157A		Soo Noto 1		6	11		6	11	mA	
lcc	'ALS158	V _{CC} = 5.5 V,	See Note 1		5	10		5	10	ШA	

[‡] All typical values are at V_{CC} = 5 V, $T_A = 25^{\circ}C$.

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS. NOTE 1: I_{CC} is measured with 4.5 V applied to all inputs and all outputs open.



SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUAD 1-OF-2 DATA SELECTORS/MULTIPLEXERS SDAS081C - APRIL 1982 - REVISED DECEMBER 1994

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5 V,$ $C_L = 50 pF,$ $R_L = 500 \Omega,$ $T_A = 25^{\circ}C$	CL RL	= 50 pF = 500 Ω	V to 5.5 V ; 2, o MAX [†]	,	UNIT	
			´ALS157A	SN54AL	S157A	SN74AL	S157A		
				TYP	MIN	MAX	MIN	MAX	
^t PLH	A or B	V	9	4	17	4	14	ns	
^t PHL	AOID	ř	6	2	15	2	12	115	
^t PLH	1	V	15	7	28	7	24	ns	
^t PHL	Ā/B	ř	9	4	20	4	17	115	
^t PLH	ы	v	14	7	25	7	20	ns	
^t PHL	9		10	4	18	4	13	115	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, C _L = 50 pF, R _L = 500 Ω, T _A = 25°C	CL RL	C = 4.5 = 50 pF = 500 Ω = MIN t	<u>),</u>	,	UNIT
			'ALS158	SN54AL	.S158	SN74AL	.S158	
			ТҮР	MIN	MAX	MIN	MAX	
^t PLH	A or B	V	9	4	18	4	15	ns
^t PHL	AUD	ř	5	2	12	2	8	115
^t PLH	Ā/B	v	13	5	22	5	18	ns
^t PHL	A/B	Ŷ	13	5	22	5	18	115
^t PLH	G	v	13	5	22	5	18	ns
^t PHL	9		13	5	22	5	18	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC}	'
Input voltage, VI	1
Operating free-air temperature range, TA: SN74AS157, SN74AS158 0°C to 70°C	;
Storage temperature range	;

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN74AS157 SN74AS158			UNIT
		MIN	NOM	MAX	
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
ЮН	High-level output current			-2	mA
IOL	Low-level output current			20	mA
ТĄ	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST COND	TEST CONDITIONS			7 8	UNIT
				MIN	TYP‡	MAX	
VIK		V _{CC} = 4.5 V,	l _l = –18 mA			-1.2	V
VOH		V_{CC} = 4.5 V to 5.5 V,	I _{OH} = -2 mA	V _{CC} -2			V
VOL		V _{CC} = 4.5 V,	I _{OL} = 20 mA		0.35	0.5	V
1.	Ā/B	\overline{A}/B V _{CC} = 5.5 V,	V. 7 V/			0.2	mA
1 ₁	A, B, or G		V ₁ = 7 V			0.1	I IIIA
1	Ā/B		VI. 07V/v			40	
ЧΗ	A, B, or G	V _{CC} = 5.5 V,	V _I =2?.Y' v			20	μA
1	Ā/B					-1	4
۱Ľ	A, B, or G	V _{CC} = 5.5 V,	VI =0.4 v			-0.5	mA
IO§		V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	mA
	SN74AS157				17.5	28	A
lcc	SN74AS158	V _{CC} = 5.5 V			15.6	22.5	mA

[‡] All typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUAD 1-OF-2 DATA SELECTORS/MULTIPLEXERS SDAS081C - APRIL 1982 - REVISED DECEMBER 1994

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5$ $C_L = 50 \text{ pF}$ $R_L = 500 \Omega$ $T_A = MIN \text{ tr}$ SN74/ MIN	<u>o</u> , o MAX†	UNIT
^t PLH	A et D	N N	1	6	
^t PHL	A or B	Y	1	5.5	ns
^t PLH	-	× ×	2	11	
^t PHL	Ā/B	Y	2	10	ns
tPLH	G	Y	2	10.5	ns
t _{PHL}	0	I	2	7.5	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 V \text{ to } 5.5 V,$ $C_{L} = 50 \text{ pF},$ $R_{L} = 500 \Omega,$ $T_{A} = \text{MIN to MAX}^{\dagger}$ $SN74AS158$ $MIN MAX$		UNIT
^t PLH	A or B	Y	1	5	ns
^t PHL			1	4.5	
^t PLH	Ā/B	Υ	2	9.5	ns
^t PHL			2	10.5	
^t PLH	G	Y	2	6.5	ns
^t PHL			2	10	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- All input pulses have the following characteristics: PRR \leq 1 MHz, t_r = t_f = 2 ns, duty cycle = 50%. D.
- The outputs are measured one at a time with one transition per measurement. E.

Figure 1. Load Circuits and Voltage Waveforms



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